Application/Control No. Applicant(s)/Patent Under Reexamination 09/756,960 YEHIA ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 3624 James Alpert **U.S. PATENT DOCUMENTS** Date **Document Number** Name Classification Country Code-Number-Kind Code MM-YYYY US-6,859,910 Α 02-2005 Croy, John Charles 715/513 US-5,315,508 05-1994 Bain et al. В 705/28 US-6,513,059 01-2003 Gupta et al. С 709/202 US-6,182,029 01-2001 D Friedman, Carol 704/9 US-Ε US-F US-G US-US-US-J US-Κ US-L US-**FOREIGN PATENT DOCUMENTS Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W

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